

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/851,725	YEH ET AL.	
Examiner	Art Unit	
Greg Bengzon	2144	

SEARCHED					
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
						
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Consulted SPE Vaughn and SPE Wiley regarding applicant arguments in Appeal Brief	1/4	\$13		
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